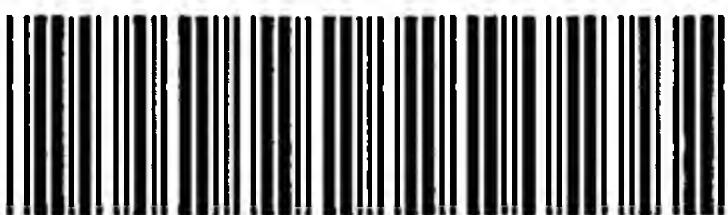


Search Notes



Application No.

10/707,021

Examiner

Chris C. Chu

Applicant(s)

BARTELO ET AL.

Art Unit

2815

SEARCHED

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

SEARCHED	DATE	EXMR
Searched in USPAT; US-PGPUB; EPO; JPO; DERWENT; and IBM-TDB;	5/26/2004	C.C.

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner